TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSIII)

SSM6N25TU

High Speed Switching Applications

- Optimum for high-density mounting in small packages
- Low on-resistance: $R_{on} = 395m\Omega (max) (@V_{GS} = 1.8 V)$
 - R_{on} = 190m Ω (max) (@V_{\mathsf{GS}} = 2.5 V)
 - R_{on} = 145m Ω (max) (@V_{\mathsf{GS}} = 4.0 V)

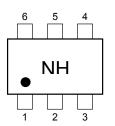
Maximum Ratings (Ta = 25°C) (Q1, Q2 Common)

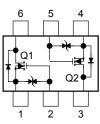
Characteristics		Symbol	Rating	Unit	
Drain-Source voltage		V _{DS}	20	V	
Gate-Source voltage		V _{GSS}	± 12	V	
Drain current	DC	Ι _D	0.5	A	
	Pulse	I _{DP}	1.5		
Drain power dissipation		P _D (Note1)	500	mW	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Note1: Mounted on FR4 board. (total dissipation) (25.4 mm \times 25.4 mm \times 1.6 t, Cu Pad: 645 mm 2)

Marking

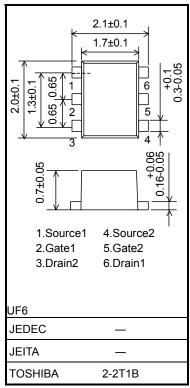
Equivalent Circuit (top view)





Handling Precaution

When handling individual devices (which are not yet mounted on a circuit board), be sure that the environment is protected against electrostatic electricity. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.



Weight: 7.0 mg (typ.)

Electrical Characteristics (Ta = 25°C) (Q1, Q2 Common)

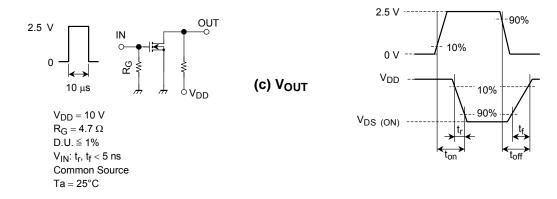
Charac	teristics	Symbol	Test Condition		Тур.	Max	Unit
Gate leakage current I _{GSS} V _{GS}		$V_{GS}=\pm 12V,\ V_{DS}=0$	_	_	±1	μA	
Drain-Source breakdown voltage		V (BR) DSS	$I_D = 1 \text{ mA}, V_{GS} = 0$	20	_	—	v
		V (BR) DSX	$I_D = 1 \text{ mA}, V_{GS} = -12 \text{ V}$	10	_	_	
Drain cut-off curre	ent	I _{DSS}	$V_{DS} = 20 V, V_{GS} = 0$	_	_	1	μA
Gate threshold vo	Itage	V _{th}	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 0.1 \text{ mA}$	0.5	_	1.1	V
Forward transfer a	admittance	Y _{fs}	$V_{DS} = 3 \text{ V}, \text{ I}_{D} = 0.25 \text{ A}$ (Note	2) 1.2	2.4	_	S
Drain-Source on-resistance		R _{DS (ON)}	$I_D = 0.25 \text{ A}, V_{GS} = 4.0 \text{ V}$ (Note	2) —	125	145	mΩ
			$I_D = 0.25 \text{ A}, V_{GS} = 2.5 \text{ V}$ (Note	2) —	150	190	
			$I_D = 0.25 \text{ A}, V_{GS} = 1.8 \text{ V}$ (Note	2) —	200	395	
Input capacitance		C _{iss}	s $V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$		268	—	pF
Reverse transfer	erse transfer capacitance C_{rss} $V_{DS} = 10 V$, $V_{GS} = 0$, f = 1 MHz		_	34	—	pF	
Output capacitance		C _{oss}	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0, \text{ f} = 1 \text{ MHz}$	_	44	—	pF
Switching time	Turn-on time	t _{on}	$V_{DD} = 10 \text{ V}, \text{ I}_{D} = 0.25 \text{ A},$	_	11	—	ns
	Turn-off time	t _{off}	V_{GS} = 0~2.5 V, R_G = 4.7 Ω	—	15	_	

Note2: Pulse test

Switching Time Test Circuit

(a) Test Circuit

(b) V_{IN}



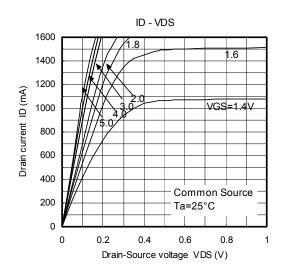
Precaution

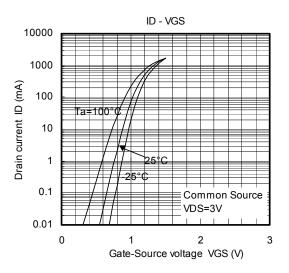
 V_{th} can be expressed as the voltage between gate and source when the low operating current value is I_D=100 μA for this product. For normal switching operation, V_{GS (on)} requires a higher voltage than V_{th} and V_{GS (off)} requires a lower voltage than V_{th}.

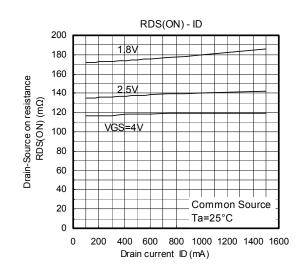
(The relationship can be established as follows: $V_{GS (off)} < V_{th} < V_{GS (on)}$)

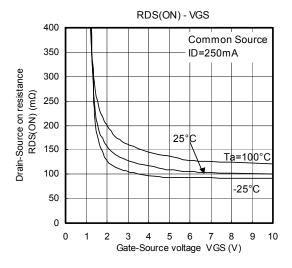
Please take this into consideration when using the device. The V_{GS} recommended voltage for turning on this product is 1.8 V or higher.

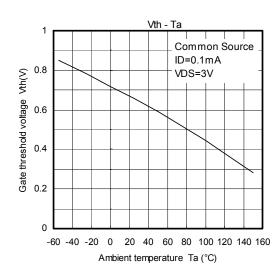
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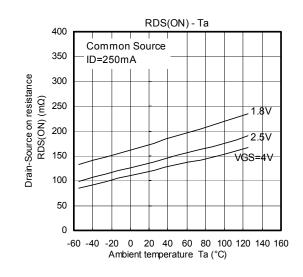




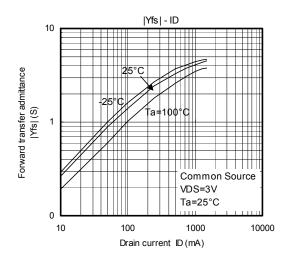


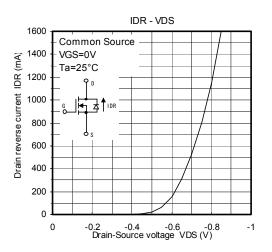


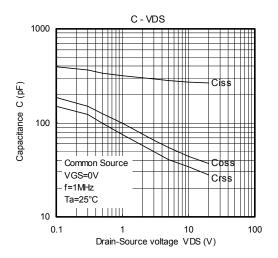


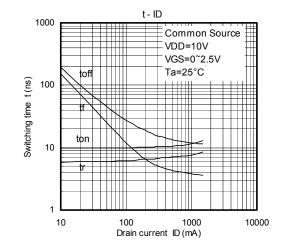


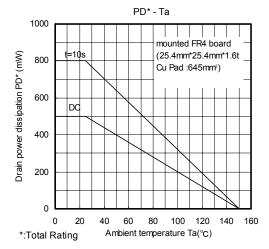
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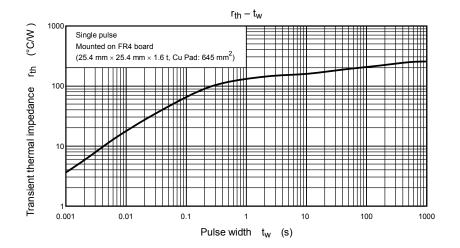








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